



## **FDU6676AS**

# N-Channel PowerTrench® SyncFET<sup>™</sup> 30V, 90A, 5.8mΩ

## **General Description**

The FDU6676AS is designed to replace a single MOSFET and Schottky diode in synchronous DC/DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low  $R_{\text{DS(ON)}}$  and low gate charge. The FDU6676AS includes a patented combination of a MOSFET monolithically integrated with a Schottky diode using Fairchild's monolithic SyncFET technology.

## **Applications**

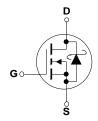
DC/DC converter

## **Features**

- R<sub>DS(ON)</sub> = 5.8mΩ Max, VGS = 10V
- $R_{DS(ON)} = 7.3 \text{m}\Omega \text{ Max}, VGS = 4.5 \text{V}$
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS}(\mbox{\scriptsize ON})}$
- · Low Gate Charge
- · High power and current handling capability
- Includes SyncFET Schottky diode







## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current –Continuous	(Note 1a)	90	Α
	–Pulsed		100	1
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1)	70	W
		(Note 1a)	3.1	1
		(Note 1b)	1.3	1
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		–55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance junction to Case	(Note 1)	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance junction to Ambient	(Note 1a)	45	
$R_{ heta JA}$	Thermal Resistance junction to Ambient	(Note 1b)	96	

**Package Marking and Ordering Information** 

Device Marking	Device	Package	Reel Size	Tape width	Quantity
FDU6676AS	FDU6676AS	I-PAK (TO-251)	Tube	N/A	75
FDU6676AS	FDU6676AS_F071 (Note 4)	I-PAK (TO-251)	Tube	N/A	75

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	urce Avalanche Ratings (Note	2)				
W <sub>DSS</sub>	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 15V, I_D = 16A$		108	250	mJ
I <sub>AR</sub>	Drain-Source Avalanche Current				16	Α
Off Chara	acteristics					
	Drain–Source Breakdown					
BV <sub>DSS</sub>	Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30			V
<u>ΔBVdss</u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA,Referenced to 25°C		29		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			500	μА
	,	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C}$		13	. 400	mA
I <sub>GSS</sub>	Gate–Body Leakage	$V_{GS} = \pm 20 \text{ V},  V_{DS} = 0 \text{ V}$			±100	nA
On Chara	cteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1	1.5	3	V
$\Delta V_{GS(th)} \ \Delta T_{J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA,Referenced to 25°C		-4		mV/°(
R <sub>DS(on)</sub>	Static Drain-Source	$V_{GS} = 10 \text{ V},  I_{D} = 16 \text{ A}$		4.8	5.8	$m\Omega$
	On–Resistance	$V_{GS} = 4.5 \text{ V},  I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V},  I_D = 16 \text{ A}, T_J = 125 ^{\circ}\text{C}$		5.8 7.7	7.3 9.6	
<b>g</b> FS	Forward Transconductance	$V_{DS} = 10 \text{ V},  I_D = 16 \text{ A}$		67		S
		150 10 1, 15 10 1	1	-		
C <sub>iss</sub>	Characteristics Input Capacitance	1		2470	1	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 15 \text{ V},  V_{GS} = 0 \text{ V},$		710		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1.0 MHz		260		pF
	Gate Resistance	V <sub>GS</sub> = 100 mV, f = 1.0 MHz		1.8		
R <sub>G</sub>		V <sub>GS</sub> = 100 IIIV, 1 = 1.0 IVITZ		1.0		Ω
	g Characteristics (Note 2)	T	1			
t <sub>d(on)</sub>	Turn-On Delay Time			12	22	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		12	22	ns
t <sub>d(off)</sub>	Turn–Off Delay Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		50	80	ns
t <sub>f</sub>	Turn–Off Fall Time			25	40	ns
t <sub>d(on)</sub>	Turn-On Delay Time	_		20	32	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		24	38	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time	$V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 $\Omega$		34	54	ns
t <sub>f</sub>	Turn–Off Fall Time			26	42	ns
Qg	Total Gate Charge, V <sub>GS</sub> = 10V			46	64	nC
Q <sub>g</sub>	Total Gate Charge, V <sub>GS</sub> = 5V	$V_{DS} = 15V$ , $I_{D} = 16 A$		25	35	nC
Q <sub>gs</sub>	Gate–Source Charge			6		nC
$Q_{gd}$	Gate-Drain Charge			7		nC

## **Electrical Characteristics**

T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sou	Drain-Source Diode Characteristics and Maximum Ratings					
Is	Maximum Continuous Drain-Source	ce Diode Forward Current			2.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.3 A (Note 2)		0.4	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 16 \text{ A},  dI_F/dt = 100 \text{ A/}\mu\text{s}$		28		ns
Q <sub>rr</sub>	Diode Reverse Recovery Charge			19		nC

#### Notes

1.  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.



a)  $R_{\theta JA} = 45$  °C/W when mounted on a  $1 in^2$  pad of 2 oz copper



b) R<sub>0JA</sub> = 96°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

3. Maximum current is calculated as:  $\sqrt{\frac{P_D}{R_{DS(ON)}}}$ 

where  $P_D$  is maximum power dissipation at  $T_C = 25^{\circ}C$  and  $R_{DS(on)}$  is at  $T_{J(max)}$  and  $V_{GS} = 10V$ . Package current limitation is 21A

4. FDU6676AS\_F071 is a lead free product. The FDU6676AS\_F071 marking will appear on the reel label.

## **Typical Characteristics**

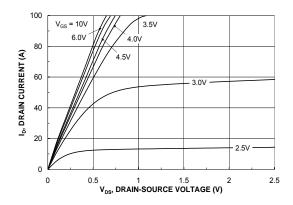


Figure 1. On-Region Characteristics

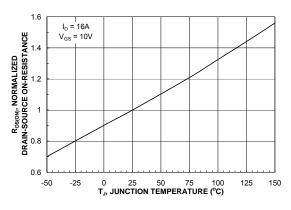


Figure 3. On-Resistance Variation with Temperature

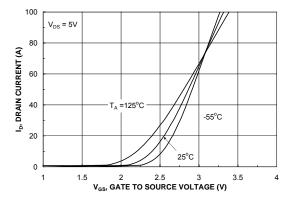


Figure 5. Transfer Characteristics

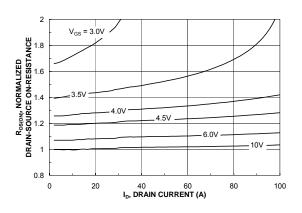


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

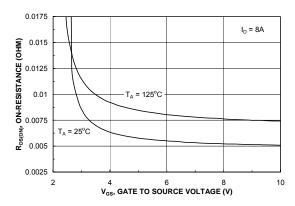


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

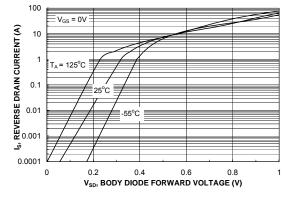
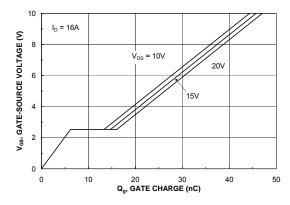


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

## **Typical Characteristics**



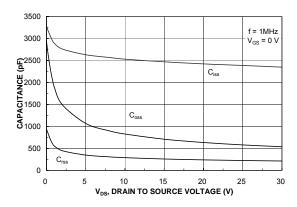
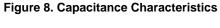
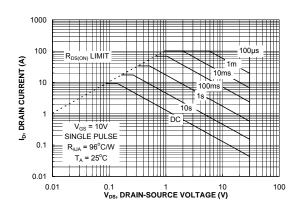


Figure 7. Gate Charge Characteristics





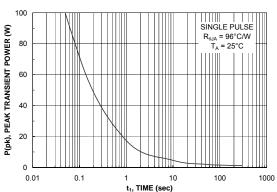


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

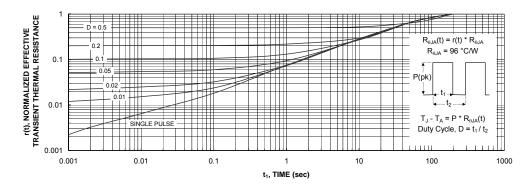


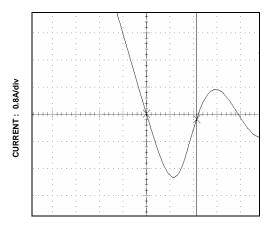
Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

## Typical Characteristics (continued)

## SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDU6676AS.



TIME: 12.5ns/div

Figure 12. FDU6676AS SyncFET Body Diode Reverse Recovery Characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDU6676A).

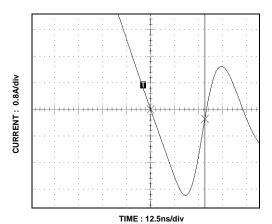


Figure 13. Non-SyncFET (FDU6676A) Body Biode Reverse Recovery Characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

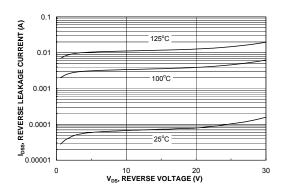


Figure 14. SyncFET Body Diode Reverse Leakage Versus Drain-Source Voltage and Temperature.





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